# **Power MOSFET** 40 V, 38 A, Single N-Channel, DPAK

#### **Features**

- Low R<sub>DS(on)</sub>
- High Current Capability
- Low Gate Charge
- These are Pb-Free Devices

#### **Applications**

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltag	е		V <sub>GS</sub>	±20	V
Continuous Drain	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	38	Α
Current – R <sub>θJC</sub>	State	T <sub>C</sub> = 100°C		27	
Power Dissipation – $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	75	W
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	7.6	Α
Current R <sub>θJA</sub> (Note 1)	$J_A$ (Note 1) State $T_A = 100^{\circ}C$			5.3	
Power Dissipation – R <sub>θJA</sub> (Note 1)	Steady State T <sub>A</sub> = 25°C		P <sub>D</sub>	2.9	W
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	75	Α
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C	
Source Current (Body Diode)			I <sub>S</sub>	36	Α
Single Pulse Drain-to Source Avalanche Energy – ( $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_{PK}$ = 17 A, L = 1 mH, $R_G$ = 25 $\Omega$ )		EAS	150	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

### THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.0	°C/W
Junction-to-Case (Note 1)	$R_{\theta JA}$	52	°C/W

1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

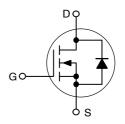


## ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX (Note 1)
40 V	21 mΩ @ 10 V	38 A

#### N-Channel





### DPAK CASE 369C STYLE 2

G

## MARKING DIAGRAM



Y = Year WW = Work Week 5407N = Specific Device Code

= Pb-Free Device

#### **ORDERING INFORMATION**

Device	Package	Shipping†
NTD5407NG	DPAK (Pb-Free)	75 Units / Rail
NTD5407NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

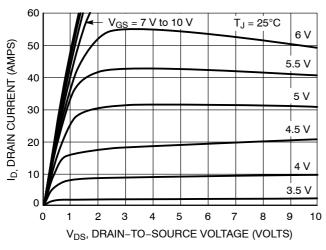
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				39		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	T <sub>J</sub> = 25°C			1.0	μΑ
			T <sub>J</sub> = 100°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>0</sub>	<sub>SS</sub> = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)			•			•	•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>E</sub>	<sub>O</sub> = 250 μA	1.5		3.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 20 A		21	26	mΩ
		V <sub>GS</sub> = 5.0 V,	I <sub>D</sub> = 10 A		32	40	
Forward Transconductance	9FS	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 18 A		15		S
CHARGES AND CAPACITANCES	-!		<u>,</u>		•		-
Input Capacitance	C <sub>ISS</sub>				615	1000	pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = V_{DS} = 3$	1.0 MHz,		173		
Reverse Transfer Capacitance	C <sub>RSS</sub>	VDS = V	52 V		80		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 38 A			20		nC
Gate-to-Source Charge	Q <sub>GS</sub>				2.25		
Gate-to-Drain Charge	$Q_{GD}$				10.5		
SWITCHING CHARACTERISTICS, V		3)					
Turn-On Delay Time	t <sub>d(ON)</sub>		Ī		6.8		ns
Rise Time	t <sub>r</sub>	V 10 V V	22 \/		17		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 32 \text{ V},$ $I_D = 38 \text{ A}, R_G = 2.5 \Omega$			66		
Fall Time	t <sub>f</sub>		-		51		
SWITCHING CHARACTERISTICS, V		)			1	l	
Turn-On Delay Time	t <sub>d(ON)</sub>		Ī		10		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 5 V, V <sub>I</sub>	20 \/		175		7
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{D} = 20 \text{ A, R}$	$_{\rm G} = 2.5  \Omega$		13		7
Fall Time	t <sub>f</sub>				23		
DRAIN-SOURCE DIODE CHARACTE	•	2)			1	ı	1
Forward Diode Voltage	ad Diada Vallaca		T <sub>J</sub> = 25°C		0.9	1.1	V
Č		$V_{GS} = 0 \text{ V},$ $I_{J} = 25^{\circ}\text{C}$ $I_{J} = 125^{\circ}\text{C}$			0.75		+
Reverse Recovery Time	t <sub>RR</sub>		<u> </u>		38		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, dI}_S/\text{dt} = 100 \text{ A/}\mu\text{s,}$ $I_S = 15 \text{ A}$			20.5		1
Discharge Time	t <sub>b</sub>				17		1
Reverse Recovery Charge	Q <sub>RR</sub>				40	1	nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

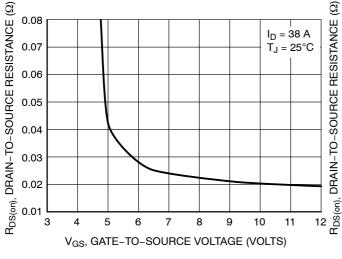
#### TYPICAL PERFORMANCE CURVES



60  $V_{DS} \ge 10 \text{ V}$ ID, DRAIN CURRENT (AMPS) 50 40 30 20  $T_J = 100^{\circ}C$ 10  $T_J = 25^{\circ}C$  $T_J = -55^{\circ}C$ 0 0 2 3 6 8 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



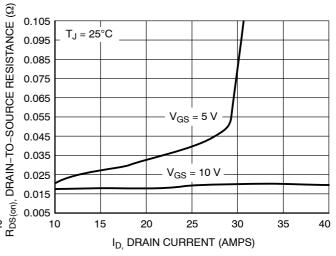
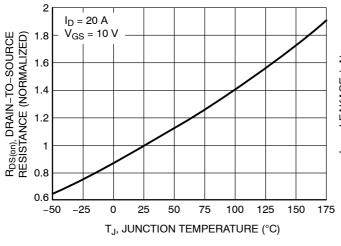


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



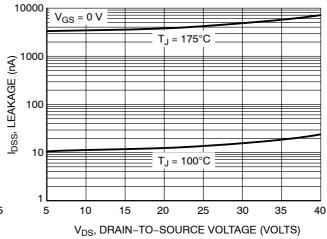
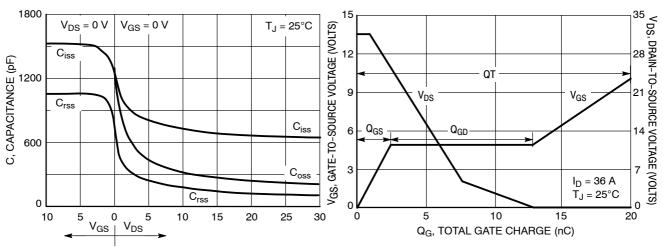


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

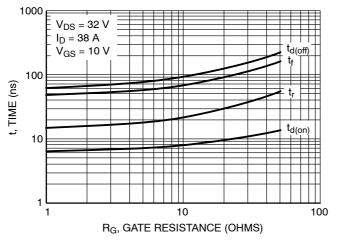


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

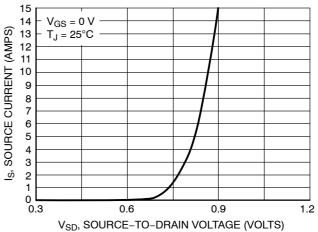


Figure 10. Diode Forward Voltage vs. Current

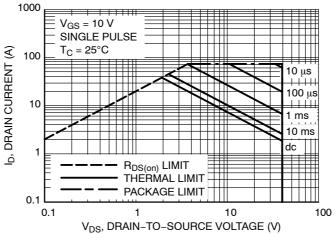


Figure 11. Maximum Rated Forward Biased Safe Operating Area

## **TYPICAL PERFORMANCE CURVES**



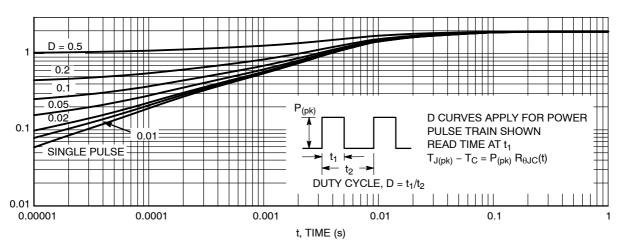
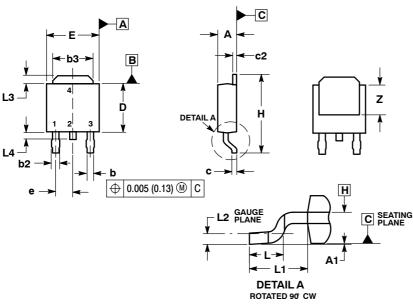


Figure 12. Thermal Response

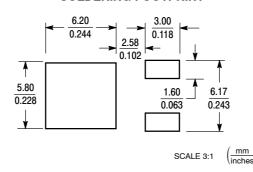
#### PACKAGE DIMENSIONS

### **DPAK (SINGLE GAUGE)**

CASE 369C-01 ISSUE D



## **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
- 2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD.
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIM	IETERS	
DIM	MIN	MAX	MIN	MAX	
A	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	0.090 BSC 2.29 BS		BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74	REF	
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE

2 DRAIN

SOURCE

4. DRAIN

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